

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10736690	ARELLANO ET AL.
Examiner	Art Unit	
Parker, Brandon	2174	

SEARCHED

Class	Subclass	Date	Examiner
715	863	10/26/2007	BP
715	530	10/26/2007	BP
715	764	10/26/2007	BP
715	762	10/26/2007	BP

SEARCH NOTES

Search Notes	Date	Examiner
Searched IEEE and ACM	10/26/2007	BP

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner